



More Channels More flexibility

Longest Memory 5 Gpt records with simple navigation

teledynelecroy.com/wr8000hd

Highest Resolution

High Signal to
Noise Input
Amplifiers

High Sample
Rate 12-bit
ADC's

Low Noise
System
Architecture

12 bits all the time 16x closer to perfect

- Clean, crisp waveforms
- More signal details
- Unmatched measurement precision



More Channels

More channels, more flexibility

- 8 channels is better than 4
- 16 channels with OscilloSYNC
- No analog/digital channel tradeoffs

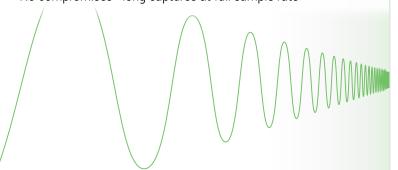




Longest Memory

5 Gpt records with simple navigation - no compromises

- 5 Gpts fast and responsive
- Simple navigation with timebase adjust or zoom traces
- No compromises long captures at full sample rate





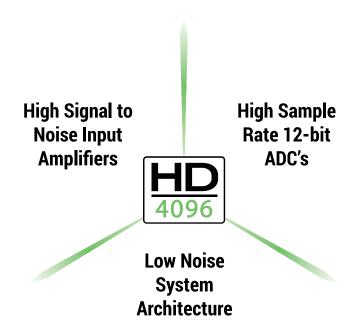
Providing 12 bits all the time, more channels than any other oscilloscope, and long memory without tradeoffs - the WaveRunner 8000HD captures every detail.

The only 8 channel, 12 bit, 2 GHz oscilloscope



HD WaveRunner 8000HD

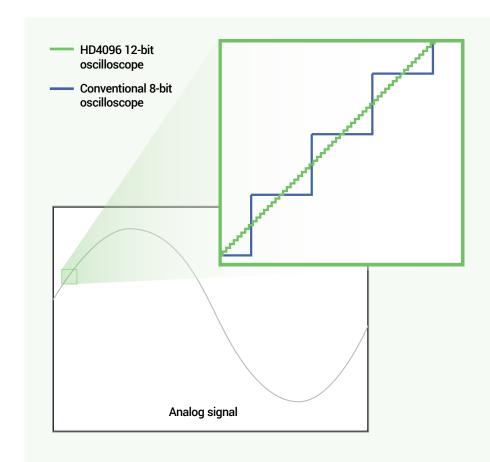
HD4096 TECHNOLOGY - 16X CLOSER TO PERFECT



Teledyne LeCroy high definition 12-bit oscilloscopes use unique HD4096 technology to provide superior and uncompromised measurement performance:

- 12-bit ADCs with high sample rates
- High signal-to-noise amplifiers
- Low noise system architecture (to 2 GHz)

Oscilloscopes with HD4096 technology have higher resolution than conventional 8-bit oscilloscopes (4096 vs. 256 vertical levels) and low noise for uncompromised measurement performance. The 12-bit ADCs support capture of fast signals at oscilloscope bandwidth ratings up to 2 GHz, while Enhanced Sample Rate to 10 GS/s ensures the highest measurement accuracy and precision. The high performance input amplifiers deliver pristine signal fidelity, and the low-noise system architecture provides an ideal signal path to ensure that signal details are delivered accurately to the oscilloscope display – 16x closer to perfect.



16x Closer to Perfect

16x more resolution

HD4096 technology provides 12 bits of vertical resolution — 16x more resolution than conventional 8-bit oscilloscopes. The 4096 discrete vertical levels reduce the quantization error compared to 256 vertical levels. This improves the accuracy and precision of the signal capture and increases measurement confidence.

EXPERIENCE THE DIFFERENCE



Experience HD4096 accuracy, detail and precision and never use an 8-bit oscilloscope again. Whether the application is general purpose design and debug, high precision analog sensors, power electronics, automotive electronics, mechatronics or other specialized applications, the HD4096 technology provides unsurpassed confidence and measurement capabilities.

Clean, crisp waveforms

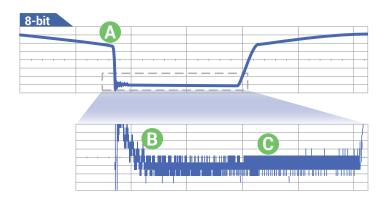
When compared to waveforms acquired and displayed using conventional 8-bit oscilloscopes, waveforms captured with HD4096 12-bit technology are dramatically crisper and cleaner, and are displayed more accurately. Once you see a waveform acquired with HD4096 technology, you will not want to go back to using a conventional 8-bit oscilloscope.

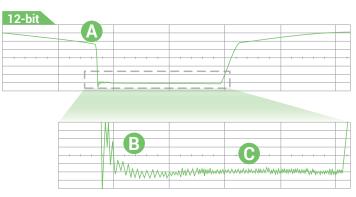
More signal details

16x more resolution provides more signal detail. This is especially helpful for analyzing wide dynamic range signals where very small amplitude signal details must be viewed. 12-bit acquisitions combined with the oscilloscope's vertical and horizontal zoom capabilities provide unparalleled insight into system behaviors and problems.

Unmatched measurement precision

HD4096 technology delivers measurement precision several times better than conventional 8-bit oscilloscopes. Higher oscilloscope measurement precision results in better ability to assess corner cases and design margins, perform root cause analysis, and create the best possible solution for any discovered design issue.



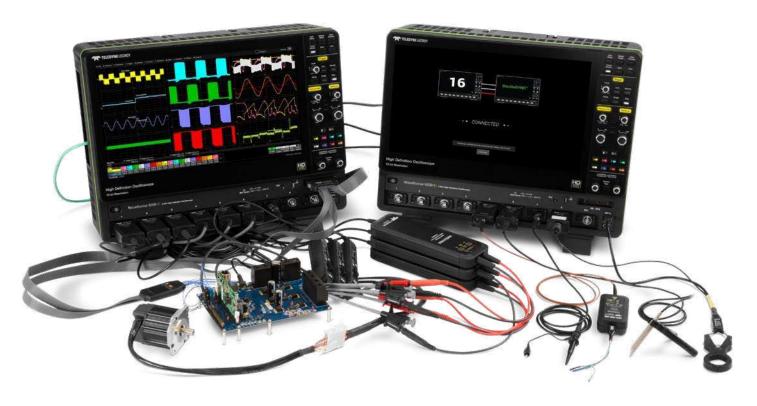


- (A) Clean, crisp waveforms | Thin traces show the actual waveform with minimal noise interference.
- B More signal details | Waveform details can now be clearly seen on an HD4096 12-bit oscilloscope.
- Unmatched measurement precision | Measurements are more precise and not affected by quantization noise.

MORE CHANNELS, MORE FLEXIBILITY



The WaveRunner 8000HD is the only oscilloscope to offer 8 analog channels and 16 digital channels, allow synchronization of two 8-channel systems, and not penalize you for using a digital channel.



8 channels is better than 4

Twice the number of channels for much less than twice the price of a four channel oscilloscope. Gain efficiency and productivity by analyzing more of your system at one time, and locate problems that would not be apparent with only four channels.

16 channels with OscilloSYNC™

View and control 16 analog channels on a single display with OscilloSYNC technology – just like having a single 16-channel acquisition system. Setup is incredibly easy with four simple steps.

No analog/digital tradeoffs

All 8 analog and 16 digital channels are always available. Other oscilloscopes require that you trade a valuable analog channel in exchange for digital inputs. With Teledyne LeCroy, you always get all the channels you paid for.

The activation key can be downloaded at no charge from: teledynelecroy.com/redeem/OscilloSYNC



OscilloSYNC Technology

- 1 Connect Ref. In/Out terminals.
- 2 Connect Aux Out terminals.
- 3 Connect Ethernet ports.
- 4 Enter IP Address and press Connect.
- → Acquire 16 channels on one display.

LONGEST MEMORY, SIMPLE NAVIGATION



With up to 5 Gpts of acquisition memory, WaveRunner 8000HD 12-bit oscilloscopes capture long periods of time, yet maintain high sample rate for visibility into the smallest details.

5 Gpts - fast and responsive

WaveRunner 8000HD oscilloscopes contain a sophisticated acquisition and memory management architecture that makes 5 Gpt acquisitions fast and responsive. More memory means more visibility into system behavior.

Simple navigation

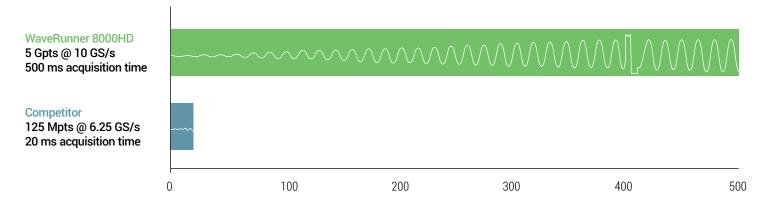
Long memory and high sample rates capture both millisecond-scale trends and picosecond-scale glitches. WaveRunner 8000HD oscilloscopes are equipped with an advanced user interface that makes it easy to find features, navigate directly using timebase scale and position knobs, or set up zoom traces - whichever you prefer. Apply analysis tools easily to any type of trace.

No compromise

WaveRunner 8000HD can acquire 500 ms of data at the full 10 GS/s sample rate - and always with 12 bits of resolution.

Oscilloscopes with less memory require trading sample rate for acquisition time.





time (ms)

www.valuetronics.com



WaveRunner 8000HD 12-bit oscilloscopes deliver 8 analog channels (16 with OscilloSYNC), 3-phase power analysis software, and high performance probes for inverter subsection, power system and control testing.

Static, Dynamic, Complete

Analyze short or long acquisitions. The mean value Numerics table summarizes static performance, while per-cycle Waveforms help you understand dynamic behaviors. Use Zoom+Gate to isolate and correlate power system behaviors to control system activity during time periods as short as a single device switching cycle.

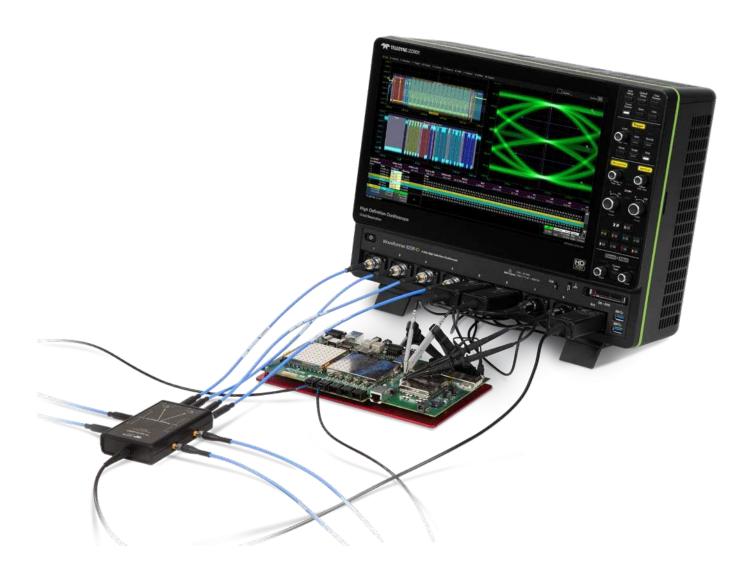
Comprehensive probing

HVD series high voltage differential probes have 65 dB CMRR at 1 MHz with 1% gain accuracy, the widest voltage ranges, and up to 6 kV commonmode rating. Connect current probes or use your own transducers with the programmable CA10 current sensor adapter to create a customized "probe". HVFO fiber-optic probes are ideal for gate drive probing.

Up to 16 analog channels

8 analog inputs at up to 2 GHz let you monitor an H-bridge's four pairs of device output and gate drive input signals. Cascaded H-bridges may be easily monitored using 12 channels, with three additional channels for output voltage. WaveRunner 8000HD has enough channels for full 3-phase power section input/output and control section analysis.





WaveRunner 8000HD 12-bit oscilloscopes combine a high channel count, long memory, and wide range of validation and debug software to best address the specific test needs of the automotive industry.

Best vehicle bus debug tools

Unique capabilities that build on our legacy serial data trigger and decode provide the most complete debug and validation of automotive buses. Cover all aspects of physical layer Automotive Ethernet testing with compliance test software and a dedicated Automotive Ethernet debug toolkit.

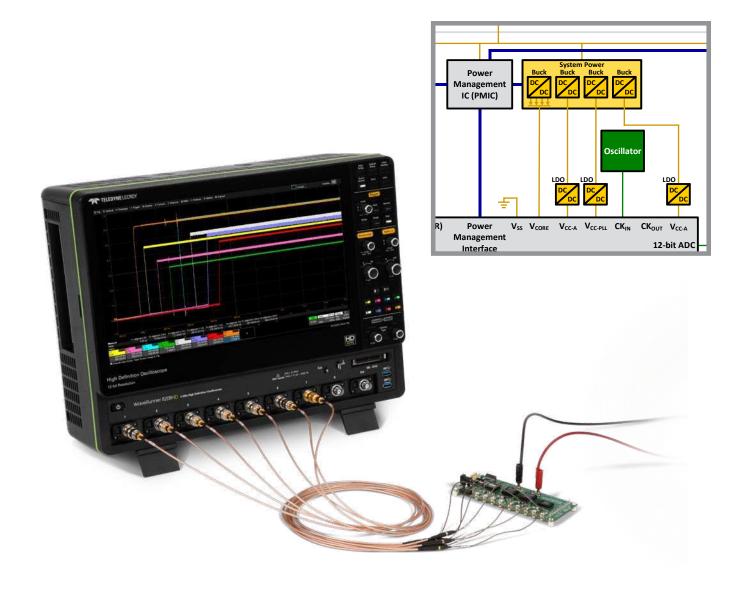
More channels for ECU debug

The flexibility of 8 12-bit analog channels and 16 digital channels make WaveRunner 8000HD the best way to analyze the array of analog, digital, and sensor signals in today's complex ECUs. Easily capture system startup behavior and perform causal analysis with 5 Gpt of memory.

EMI/EMC pre-compliance test

12-bit resolution for spectral analysis provides more insight. Specialized EMC/EMI pulse parameters provide measurement flexibility. Support for all relevant electrical and magnetic field units of measure. Capability to measure sub-1 Hz magnetic field strengths.





WaveRunner 8000HD 12-bit oscilloscopes' high resolution, long memory and high channel count let you validate and debug all aspects of power supply, delivery and consumption - for complete confidence.

Accurate PDN measurements

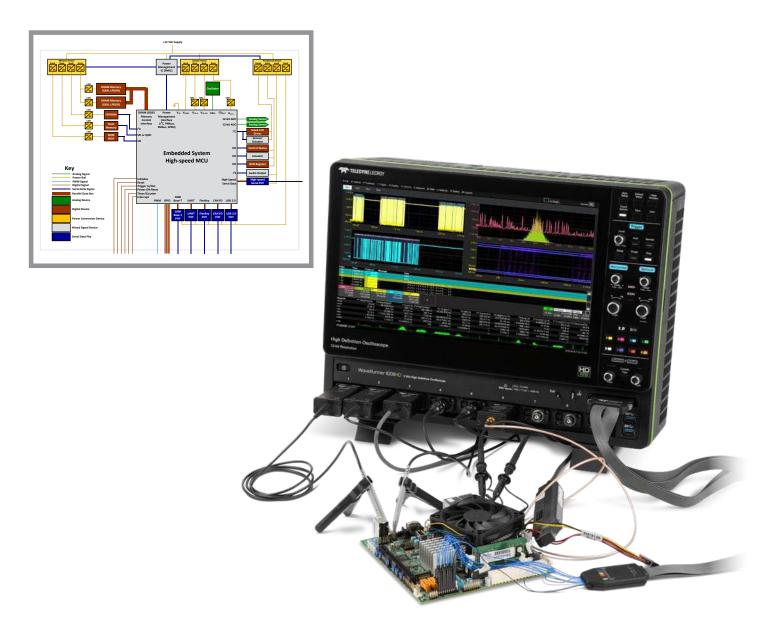
Make sensitive measurements like rail collapse characterization with total confidence thanks to WaveRunner 8000HD's high dynamic range and 0.5% gain accuracy. Its HD4096 architecture means an exceptionally low noise floor, for easily pinpointing noise sources.

Specialized power probes

Combine WaveRunner 8000HD with the RP4030 4 GHz Power Rail Probe for unsurpassed insight into PDN behavior. The variety of probe tips ensures easy connectivity, and its low loading characteristics minimize disruption to the device under test.

Power sequencing

8 analog channels with 12-bit resolution and high offset capability give full visibility into power sequencing behavior - with 16 digital inputs available to decode and trigger on SPMI and other power management interfaces. Up to 5 Gpts of acquisition memory to capture every detail.



WaveRunner 8000HD 12-bit oscilloscopes acquire the longest records at the highest resolution for the most comprehensive deeply embedded computing system analysis (analog, digital, serial data, and sensor).

Powerful, deep toolbox

More standard math, measure, pass/fail and other tools than other oscilloscopes provide faster and more complete insight into circuit problems. Many additional application packages are optionally available to enhance understanding.

8 channels with long captures

8 channels with 12-bit resolution make the WaveRunner 8000HD the best performing oscilloscope for embedded systems testing, specifically those with sensor signals. 5 Gpts of memory captures every detail when performing causal analysis.

Comprehensive probe offering

A wide selection of low voltage, high voltage and current probes accurately measures every signal in your circuit. Additional probe adapters easily integrate third-party probes.

WAVERUNNER 8000HD OSCILLOSCOPES AT A GLANCE





Key Attributes

- 1. 15.6" 1900 x 1080 capacitive touchscreen display
- 2. 8 analog input channels
- 3. ProBus input supports every Teledyne LeCroy probe
- **4.** MAUI with OneTouch user interface for intuitive and efficient operation
- 5. Q-Scape multi-tab display architecture
- **6.** Up to 5 Gpts of acquisition memory
- 7. HD4096 technology 12 bits all the time
- **8.** Buttons/indicators color-coded to associated waveform on display

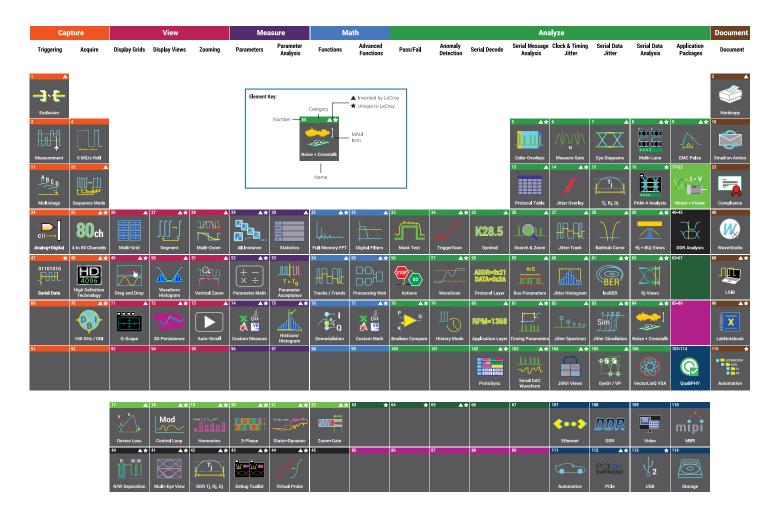
- **9.** Use cursors and adjust settings without opening a menu
- **10.** Mixed Signal capability with 16 integrated digital channels
- 11. 6 USB 3.1 ports (2 front, 4 side)
- **12.** HDMI and DisplayPort supports 4K (4096 x 2304) external monitor
- 13. Removable SSD (standard)
- **14**. View 16 channels on one display with OscilloSYNC
- **15.** Reference Clock Input/Output for connecting to other equipment
- **16.** USBTMC over USB 3.1 for fast data offload





POWERFUL, DEEP TOOLBOX





Our heritage

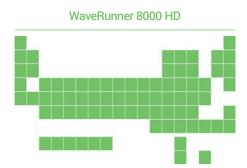
Teledyne LeCroy's 50+ year heritage is in processing long records to extract meaningful insight. We invented the digital oscilloscope and many of the additional waveshape analysis tools.

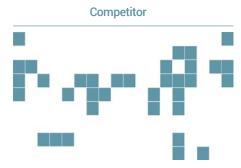
Our obsession

Our tools and operating philosophy are standardized across much of our product line. This deep toolbox inspires insight; and your moment of insight is our reward.

Our invitation

Our Periodic Table of Oscilloscope
Tools explains the toolsets that
Teledyne LeCroy has deployed in our
oscilloscopes. Visit our interactive
website to learn more about them.
teledynelecroy.com/tools







Teledyne LeCroy offers an extensive range of probes to meet virtually every probing need.

ZS Series High Impedance Active Probes

ZS1000, ZS1000-QUADPAK ZS1500, ZS1500-QUADPAK



High input impedance (1 M Ω), low 0.9 pF input capacitance and an extensive set of probe tips and ground accessories make these low-cost, single-ended probes ideal for a wide range of applications. The ZS Series is available up to 4 GHz bandwidth.

Differential Probes (200 MHz – 1.5 GHz)

ZD1500, ZD1000, ZD500, ZD200 AP033



High bandwidth, excellent common-mode rejection ratio (CMRR) and low noise make these active differential probes ideal for applications such as automotive electronics and data communications. AP033 provides 10x gain for high-sensitivity measurement of series/shunt resistor voltages.

Active Voltage/Power Rail Probe

RP4030



Specifically designed to probe a low impedance power/voltage rail. The RP4030 has 30 V built-in offset adjust, low attenuation (noise), and high DC input impedance with 4 GHz of bandwidth. Featuring a wide assortment of tips and leads, including solderin and U.FL receptacle connections.

High Voltage Fiber Optically isolated Probe

HVF0103

The HVFO103 is a compact, simple, affordable probe for measurement of small signals (gate drives, sensors, etc.) floating on an HV bus in power electronics designs, or for EMC, EFT, ESD and RF immunity testing sensor monitoring. Suitable for up to 35 kV common-mode. 140 dB CMRR.

HVD Series High Voltage Differential Probes

HVD3102A, HVD3106A(1 kV) HVD3206A (2 kV) HVD3605A (6 kV)



Available with 1, 2 or 6 kV common-mode ratings. Excellent CMRR (65 dB @ 1 MHz) at high frequencies is combined with low inherent noise, wide differential voltage range, high offset voltage capabilities, and 1% gain accuracy. The ideal probe for power conversion system test.

High Voltage Passive Probes

HVP120, PPE4KV, PPE5KV, PPE6KV



The HVP and PPE series includes four fixed-attenuation probes covering a range from 1 kV to 6 kV. These probes are ideal for lightning/surge or EFT testing, or for probing in-circuit beyond the range of an LV-rated passive probe.

Current Probes

CP030, CP030-3M, CP030A CP031, CP031A CP150, CP150-6M CP500, DCS025



Available in bandwidths up to 100 MHz with peak currents of 700 A and sensitivities to 1 mA/div. Extra-long cables (3 or 6 meters) available on some models. Ideal for component or power conversion system input/output measurements. DCS015 deskew calibration source also available.

Probe and Current Sensor Adapters

TPA10, CA10, CA10-QUADPAK



TPA10 adapts supported Tektronix TekProbe-compatible probes to the Teledyne LeCroy ProBus interface. CA10 is a programmable adapter for third-party current sensors that have voltage or current outputs proportional to measured current. QUADPAKs of four pieces each are available.



Analog Bandwidth @ 500 (4 G db) 350 MHz 500 MHz	Vertical - Analog Channels	WaveRunner 8038HD	WaveRunner 8058HD	WaveRunner 8108HD	WaveRunner 8208HD
Apriliage From (10-9%, 50 g)		350 MHz	500 MHz	1 GHz	2 GHz
Rise Time (10-978, 50 Q)					
Rise Time (20~60%, 50.0) 750 ps 8.25 ps 300 ps 176 ps					
Input Channels					
Vertical Resolution			525 ps	300 ps	170 ps
Effective Number of Bits (FIACH)			la a constantina (EDEO)		
Vertical Noise Floor (mis. 50.92) 1.mV/div 95 µV 100 µV 130 µV 170 µV					
1 mV/dw		8.9 bits	8.8 bits	8.6 bits	8.4 bits
2 mV/div					
Sint/John					
10 mV/div 115 μV	2 mV/div	95 μV	100 μV	130 μV	170 μV
180 µV	5 mV/div	100 μV	105 μV	135 μV	175 μV
20 mV/div 130 µV 145 µV 235 µV 330 µV 250 µV 330 µV 510 µV 250 µV 330 µV 510 µV 250 µV 330 µV 510 µV 220 mV 250 mV 325 mV 310 µV 225 mV 330 µV 510 µV 2.25 mV 3.0 mV 1.45 mV 2.25 mV 3.25 mV 2.00 mV 2.50 mV 3.25 mV 3.25 mV 2.95 mV 3.15 mV 4.00 mV 5.20 mV 5.20 mV 5.00 µV 5.	10 mV/div	115 µV	125 µV	155 µV	200 µV
Sp mV/div 185 μV 200 μV 250 μV 330 μV 510 μV 200 mV 250 μV 235 mV 200 mV 250 mV 2.35 mV 2.35 mV 2.35 mV 3.35 mV 2.00 mV 2.50 mV 3.25 mV 4.00 mV 5.20 mV 5			145 µV		235 µV
100 mV/div 285 μV	50 mV/div		200 uV	250 µV	
1.45 mV					
Sensitivity					
Sensitivity					
Sensitivity					
Commonstrated Commonstrate Com					J.ZU IIIV
(Gain Component of DC Accuracy) Channel-Channel Isolation 70 dB up to 200 MHz 60 dB up to 350 MHz 60 dB up to 500 MHz 50 dB up to 1 GHz 50 dB up to 1 GHz 50 dB up to 1 GHz 60 dB up to 500 MHz 50 dB up to 1 GHz 60 dB up to 500 MHz 60 dB up to 500 MHz 50 dB up to 1 GHz 60 dB up to 500 MHz 60 dB up to 2 GHz 60 dB up to 500 MHz 60 dB up to 500 MHz 60 dB up to 2 GHz 60 dB up to 500 MHz 60 dB up to 500 MHz 60 dB up to 2 GHz 60 dB up to 500 MHz 60 dB up to 2 GHz 60 dB up to 500 MHz 60 dB up to 2 GHz 60 dB up to 500 MHz 60 dB up to 2 GHz 60 dB up to 500 MHz 60 dB up to 2 GHz 60 dB up to 500 MHz 60 dB up to 2 GHz 60 dB up to 500 MHz 60 dB up to 2 GHz 60 dB up to 500 MHz 60 dB up to 50 MHz 60 dB up to 500 MHz 60 dB up to 50			iable; I MISE: I MV-10 V/div,	runy variable	
Channel Channel Isolation		±(U.5%) FS, offset at 0 V			
60 dB up to 350 MHz					
Offset Range 1 mV to 4.95 mV: ±1.6 V S mV to 9.9 mV: ±4 V 10 mV to 19.8 mV: ±8 V.20 mV to 1 V: ±10 V 10 mV to 19.8 mV: ±8 V.20 mV to 1 V: ±10 V 10 mV to 19.8 mV: ±8 V.20 mV to 1 V: ±10 V 10 mV to 19.8 mV: ±1.5 V.5 mV to 9.9 mV: ±4 V 10 mV to 19.8 mV: ±1.5 V.5 mV to 9.9 mV: ±4 V 10 mV to 19.8 mV: ±1.5 V.5 mV to 10 mV: ±16 V 10 mV to 19.8 mV: ±10 V 10 mV to 1	Channel-Channel Isolation				
The first Range So 0: 1 mV to 4.95 mV: ±1.6 V, 5 mV to 9.9 mV: ±4 V 10 mV to 19.8 mV: ±8 V, 20 mV to 1 V: ±10 V 1 MΩ: 1 mV to 4.95 mV: ±1.6 V, 5 mV to 9.9 mV: ±4 V 10 mV to 19.8 mV: ±8 V, 20 mV to 1 V: ±10 V 1 MΩ: 1 mV to 4.95 mV: ±1.6 V, 5 mV to 9.9 mV: ±4 V 10 mV to 19.8 mV: ±8 V, 20 mV to 100 mV: ±16 V 10 mV to 19.8 mV: ±8 V, 20 mV to 100 mV: ±16 V 10 mV to 19.8 mV: ±8 V, 20 mV to 100 mV: ±16 V 10 mV to 19.8 mV: ±80 V, 200 mV to 11 V: ±160 V 10.2 V to 10 V: ±400 V 10 mV to 19.8 mV: ±80 V, 200 mV to 11 V: ±160 V 10.2 V to 10 V: ±400 V 10 mV to 19.8 mV: ±80 V, 200 mV to 10 V: ±400 V 10 mV to 19.8 mV: ±80 V, 200 mV to 10 V: ±400 V 10 mV to 19.8 mV: ±80 V, 200 mV to 10 V: ±400 V 10 mV to 10 mV to 10 V: ±400 V 10 V:		60 dB up to 350 MHz	60 dB up to 500 MHz		60 dB up to 500 MHz
To with the content of the conten				50 dB up to 1 GHz	
1 mV to 4.95 mV: ±1.6 v, 5 mV to 9 p mV: ±4 v 10 mV to 19.8 mV: ±8 v, 20 mV to 1 v: ±10 v 1 MΩ: 1 mV to 4.95 mV: ±1.6 v, 5 mV to 9.9 mV: ±4 v 10 mV to 19.8 mV: ±8 v, 20 mV to 100 mV: ±16 v 102 mV to 19.8 mV: ±8 v, 20 mV to 100 mV: ±16 v 102 mV to 19.8 mV: ±80 v, 20 mV to 10 v: ±16 v 102 mV to 19.8 mV: ±80 v, 20 mV to 10 v: ±16 v 102 mV to 19.8 mV: ±80 v, 20 mV to 10 v: ±16 v 102 vV to 10 vV: ±400 v Maximum Input Voltage 50 Ω: 5 Vrms, ± 10 V Peak 1 MΩ: 400 V max. (DC + Peak AC ≤ 10 kHz) Input Coupling 1 MΩ: 400 V max. (DC + Peak AC ≤ 10 kHz) Input Coupling 1 1 MΩ: AC, DC, GND, 500 D. DC, GND Input Impedance 50 Ω: 2% or 1 MΩ 19 pF, 10 MΩ 10 pF Bandwidth Limiters 20 MHz, 200 MHz 20 MHz, 200 MHz 350 MHz 350 MHz, 500 MHz 350 MHz, 500 MHz 360 MHz, 500 MHz					40 dB up to 2 GHz
10 mV to 19.8 mV: ±8 V, 20 mV to 1 V: ±10 V 1 mV to 4.95 mV: ±1.6 V,5 mV to 9.9 mV: ±4 V 10 mV to 19.8 mV: ±1.6 V,5 mV to 9.9 mV: ±4 V 10 mV to 19.8 mV: ±8 V, 20 mV to 10 mV: ±16 V 10.2 mV to 19.8 mV: ±8 V, 20 mV to 10 mV: ±16 V 10.2 mV to 19.8 mV: ±8 V, 20 mV to 10 mV: ±16 V 10.2 mV to 19.8 mV: ±8 V, 20 mV to 10 mV: ±16 V 10.2 mV to 10 V: ±400 V 1.02 V to 10 V: ±400 V 1.02 V to 10 V: ±400 V 1.02 V to 10 V: ±400 V 1.02 V to 10 V: ±400 V 1.02 V to 10 V: ±400 V 1.02 V to 10 V: ±400 V 1.02 V to 10 V: ±400 V 2.0 MHz, 200 MHz, 200 MHz, 200 MHz, 20 MHz, 20 MHz, 20 MHz, 200 MHz, 2	Offset Range				
T MOL 1 mV to 4,95 mV : ±16 15, 15 mV to 9,9 mV : ±4 V 10 mV to 19.8 mV : ±8 V, 20 mV to 100 mV : ±16 V 102 mV to 19.8 mV : ±8 V, 20 mV to 100 mV : ±16 V 102 mV to 19.8 mV : ±80 V, 200 mV to 10 v : ±16 V 102 mV to 19.8 mV : ±80 V, 200 mV to 10 v : ±16 V 102 mV to 19.8 mV : ±10 V = 10.0 v 100 v : ±400 V 100			1 mV to 4.95 mV: ±1.6	V, 5 mV to 9.9 mV: ±4 V	
1 mV to 4,95 mV: ±1.6 V,5 mV to 9 g mV: ±4 V 10 mV to 19 8 mV: ±9.2 mV to 100 mV: ±16 V 102 mV to 198 mV: ±30 V, 200 mV to 100 mV: ±16 V 102 mV to 198 mV: ±80 V, 200 mV to 10 mV: ±160 V 1.02 V to 10 V: ±400 V 1.02 V to 10 V: ±400 V 1.02 V to 10 V: ±400 V 4.05% of offset value + 0,5% FS +1 mV) Maximum Input Voltage 50 0: 5 Vms, ±10 V Peak 1 M0: 400 V max, (DC + Peak AC ≤ 10 kHz) Input Coupling 1 MΩ: 400 V max, (DC + Peak AC ≤ 10 kHz) Input Impedance 50 0±2% or 1 M0 19 pF, 10 M0 10 pF Bandwidth Limiters 20 MHz, 200 MHz 350			10 mV to 19.8 mV: ±8	3 V, 20 mV to 1 V: ±10 V	
10 mV to 198 mV: ±80 v, 200 mV to 100 mV: ±16 V					
10 mV to 198 mV: ±80 v, 200 mV to 100 mV: ±16 V			1 mV to 4.95 mV: ±1.6	V. 5 mV to 9.9 mV: ±4 V	
102 mV to 198 mV: ±80 V, 200 mV to 1 V: ±160 V					
1.02 V to 10 V: ±400 V					
DC Vertical Offset Accuracy ±(0.5% of offset value + 0.5% FS + 1 mV)					
Maximum Input Voltage S0 Ω: 5 Vrms, ± 10 V Peak 1 MΩ: 400 V max. (DC + Peak AC ≤ 10 kHz)	DC Vertical Offset Accuracy	+(0.5% of offset value + 0.5%		0 1. = 100 1	
1 MΩ: 400 V max. (DC+ Peak AC s 10 kHz) Input Coupling 1 MΩ: AC, DC, GND, 50 Ω: DC, GND 1 MΩ 10 pF			013 + 1111V)		
Input Coupling	Maximum input voitage		L AO . 10 LU=)		
Input Impedance 50 Ω ±2% or 1 MΩ 19 pF, 10 MΩ 10 pF					
Bandwidth Limiters 20 MHz, 200 MHz 20 MHz, 200 MHz, 350 MHz, 200 MHz, 350 MHz, 300 MHz, 300 MHz, 500 MHz 350 MHz, 500 MHz					
Rescaling Length: meters, inches, feet, yards, miles; Mass: grams, slugs; Temperature: Celsius, Fahrenheit, Kelvin; Angle: radian, arcdegr, arcmin, arcsec, cycles, revolutions, turns; Velocity: m/s, in/s, ft/s, yd/s, miles/s; Acceleration: m/s2, in/s2, ft/s2, g0; Volume: liters, cubic meters, cubic inches, cubic feet, cubic yards; Force (Weight): Newton, grain, ounce, pound; Pressure: Pascal, bar, atmosphere (technical), atmosphere (start torr, psi; Electrical: Volts, Amps, Watts, Volt-Amperes reactive, Farad, Coulomb, Ohm, Siemen, Volt/meter, Coulomb/m2, Farad/orneter, Siemen/meter, power factor; Magnetic: Weber, Tesla, Henry, Amp/met Henry/meter; Energy: Joule, BTU, calorie; Rotating Machine: radian/second, frequency, revolution/second, revolution/minute, N·m, lb-ft, lb-in, oz-in, Watt, horsepower; Other: % Horizontal - Analog Channels Time/Division Range Internal timebase common to 8 input channels Time/Division Range 100 ps/div to 5 ks/div (up to 10 ks/div with 500MPT memory, 25 ks/div with 1000MPT memory, 50 ks/div w 200MPT memory, 100 ks/div with 500MPT memory); Rolf Mode available at ≥ 100 ms/div and ≤ 5 MS/s Clock Accuracy ±1 ppm +1 ppm/year from calibration Sample Clock Jitter Up to 10 µs Acquired Time Range: 80 fsrms (Internal Timebase Reference) Up to 10 ms Acquired Time Range: 150 fsrms (Internal Timebase Reference) Delta Time Measurement Accuracy √2 * √ (Noise SlewRate) / (Sample Clock Jitter)² (RMS) + (clock accuracy * reading) (seconds) Jitter Measurement Floor Channel-Channel Deskew Range ±9 x time/div. setting, 100 ms max., each channel External Timebase Reference (Input) 10 MHz ±25 ppm at 0 to 10 dBm into 50 0 hms	Input Impedance	50 Ω ±2% or 1 MΩ 19 pF, 10) MΩ 10 pF		
Length: meters, inches, feet, yards, miles; Mass: grams, slugs; Temperature: Celsius, Fahrenheit, Kelvin; Angle: radian, arcdegr, arcmin, arcsec, cycles, revolutions, turns; Velocity: m/s, in/s, ft/s, yd/s, miles/s; Acceleration: m/s2, in/s2, ft/s2, g0; Volume: liters, cubic meters, cubic inches, cubic det, cubic yards; Force (Weight): Newton, grain, ounce, pound; Pressure: Pascal, bar, atmosphere (technical), atmosphere (start torr, psi; Electrical: Volts, Amps, Watts, Volt-Amperes, Volt-Amperes reactive, Farad, Coulomb, Ohm, Siemen, Volt/meter, Coulomb/m2, Farad/meter, Siemen/meter, power factor; Magnetic: Weber, Tesla, Henry, Amp/met Henry/meter; Energy: Joule, BTU, calorie; Rotating Machine: radian/second, frequency, revolution/second, revolution/minute, N·m, Ib-ft, Ib-in, oz-in, Watt, horsepower; Other: % Horizontal - Analog Channels	Bandwidth Limiters	20 MHz, 200 MHz	20 MHz, 200 MHz,	20 MHz, 200 MHz,	20 MHz, 200 MHz,
Length: meters, inches, feet, yards, miles; Mass: grams, slugs; Temperature: Celsius, Fahrenheit, Kelvin; Angle: radian, arcdegr, arcmin, arcsec, cycles, revolutions, turns; Velocity: m/s, in/s, ft/s, yd/s, miles/s; Acceleration: m/s2, in/s2, ft/s2, g0; Volume: liters, cubic meters, cubic inches, cubic feet, cubic yards; Force (Weight): Newton, grain, ounce, pound; Pressure: Pascal, bar, atmosphere (technical), atmosphere (star torr, psi; Electrical: Volts, Amps, Watts, Volt-Amperes, Volt-Amperes reactive, Farad, Coulomb, Ohm, Siemen, Volt/meter, Coulomb/m2, Farad/meter, Siemen/meter, power factor; Magnetic: Weber, Tesla, Henry, Amp/met Henry/meter; Energy: Joule, BTU, calorie; Rotating Machine: radian/second, frequency, revolution/second, revolution/minute, N·m, Ib-ft, Ib-in, oz-in, Watt, horsepower; Other: % Horizontal - Analog Channels			350 MHz	350 MHz, 500 MHz	350 MHz, 500 MHz, 1 GHz
Angle: radian, arcdegr, arcmin, arcsec, cycles, revolutions, turns; Velocity: m/s, in/s, ft/s, yd/s, miles/s; Acceleration: m/s2, in/s2, ft/s2, g0; Volume: liters, cubic meters, cubic inches, cubic feet, cubic yards; Force (Weight): Newton, grain, ounce, pound; Pressure: Pascal, bar, atmosphere (technical), atmosphere (star torr, psi; Electrical: Volts, Amps, Watts, Volt-Amperes, Volt-Amperes reactive, Farad, Coulomb, Dhn, Siemen, Volt/meter, Coulomb/m2, Farad/meter, Siemen/meter, power factor; Magnetic: Weber, Tesla, Henry, Amp/met Henry/meter; Energy: Joule, BTU, calorie; Rotating Machine: radian/second, frequency, revolution/second, revolution/minute, N·m, lb-ft, lb-in, oz-in, Watt, horsepower; Other: % Horizontal - Analog Channels Time/Division Range Internal timebase common to 8 input channels Time/Division Range Internal timebase common to 8 input channels Time/Division Range Internal timebase common to 8 input channels Time/Division Range Internal timebase common to 8 input channels Internal timebase common to 8 input channels Time/Division Range Internal timebase common to 8 input channels Time/Division Range Internal timebase common to 8 input channels Internal timebase Reference) Up to 10 us Acquired Time Range: 80 fsrms (Internal Timebase Reference) Up to 10 us Acquired Time Range: 150 fsrms (Internal Timebase Reference) Internal timebase Reference) Internal timebase Reference (Input)	Rescaling	Length meters inches feet	vards miles Mass grams sli	ugs: Temperature: Celsius, Fal	
Acceleration: m/s2, in/s2, ft/s2, g0; Volume: liters, cubic meters, cubic inches, cubic feet, cubic yards; Force (Weight): Newton, grain, ounce, pound; Pressure: Pascal, bar, atmosphere (technical), atmosphere (start torr, psi; Electrical: Volts, Amps, Watts, Volt-Amperes, Volt-Amperes reactive, Farad, Coulomb, Ohm, Siemen, Volt/meter, Coulomb/m2, Farad/meter, Siemen/meter, power factor; Magnetic: Weber, Tesla, Henry, Amp/met Henry/meter; Energy: Joule, BTU, calorie; Rotating Machine: radian/second, frequency, revolution/second, revolution/minute, N·m, lb-ft, lb-in, oz-in, Watt, horsepower; Other: % Horizontal - Analog Channels Timebases Internal timebase common to 8 input channels Time/Division Range 100 ps/div to 5 ks/div (up to 10 ks/div with 500MPT memory, 25 ks/div with 1000MPT memory, 50 ks/div w 2000MPT memory, 100 ks/div with 5000MPT memory); Roll Mode available at ≥ 100 ms/div and ≤ 5 MS/s Clock Accuracy ±1 ppm +1 ppm/year from calibration Sample Clock Jitter Up to 10 µs Acquired Time Range: 80 fsrms (Internal Timebase Reference) Up to 10 µs Acquired Time Range: 150 fsrms (Internal Timebase Reference) Up to 10 ms Acquired Time Range: 150 fsrms (Internal Timebase Reference) Up to 10 ms Acquired Time Range: 150 fsrms (Internal Timebase Reference) Jitter Measurement Floor Channel-Channel Deskew Range ±9 x time/div. setting, 100 ms max., each channel External Timebase Reference (Input) 10 MHz ±25 ppm at 0 to 10 dBm into 50 Ohms	9				
Force (Weight): Newton, grain, ounce, pound; Pressure: Pascal, bar, atmosphere (technical), atmosphere (star torr, psi; Electrical: Volts, Amps, Watts, Volt-Amperes, Volt-Amperes reactive, Farad, Coulomb, Ohm, Siemen, Volt/meter, Coulomb/m2, Farad/meter, Siemen/meter, power factor; Magnetic: Weber, Tesla, Henry, Amp/met Henry/meter; Energy: Joule, BTU, calorie; Rotating Machine: radian/second, frequency, revolution/second, revolution/minute, N·m, lb-ft, lb-in, oz-in, Watt, horsepower; Other: % Horizontal - Analog Channels Timebases Internal timebase common to 8 input channels Time/Division Range 100 ps/div to 5 ks/div (up to 10 ks/div with 500MPT memory, 25 ks/div with 1000MPT memory, 50 ks/div watth 500MPT memory); Roll Mode available at ≥ 100 ms/div and ≤ 5 MS/s Clock Accuracy \$\frac{1}{2} \text{ppm} + 1 \text{ppm}/year from calibration}\$ Sample Clock Jitter Up to 10 \text{ps} Acquired Time Range: 80 fsrms (Internal Timebase Reference)}\$ Up to 10 \text{ms} Acquired Time Range: 150 fsrms (Internal Timebase Reference)}\$ Up to 10 \text{ms} Acquired Time Range: 150 fsrms (Internal Timebase Reference)}\$ Jitter Measurement Floor \$\sqrt{\frac{Noise}{SlewRate}}^2 + \text{(Sample Clock Jitter)}^2 \text{(RMS)} + \text{(clock accuracy * reading) (seconds)}\$ ### Channel-Channel Deskew Range ### Lenry/Amp/metr					
torr, psi; Electrical: Volts, Amps, Watts, Volt-Amperes reactive, Farad, Coulomb, Ohm, Siemen, Volt/meter, Coulomb/m2, Farad/meter, Siemen/meter, power factor; Magnetic: Weber, Tesla, Henry, Amp/met Henry/meter; Energy: Joule, BTU, calorie; Rotating Machine: radian/second, frequency, revolution/second, revolution/minute, N·m, lb-ft, lb-in, oz-in, Watt, horsepower; Other: % Horizontal - Analog Channels Timebases Internal timebase common to 8 input channels Time/Division Range 100 ps/div to 5 ks/div (up to 10 ks/div with 500MPT memory, 25 ks/div with 1000MPT memory, 50 ks/div w 2000MPT memory, 100 ks/div with 5000MPT memory); Roll Mode available at ≥ 100 ms/div and ≤ 5 MS/s Clock Accuracy \$\frac{1}{2} \text{ ppm} + 1 \text{ ppm/year from calibration}\$\$ Sample Clock Jitter Up to 10 ms Acquired Time Range: 80 fsrms (Internal Timebase Reference) Up to 10 ms Acquired Time Range: 150 fsrms (Internal Timebase Reference) Up to 10 ms Acquired Time Range: 150 fsrms (Internal Timebase Reference) Delta Time Measurement Accuracy \[\sum_{\text{Noise}} \sum_{\text{SlewRate}} \sum_{\text{P}}^2 \text{ (Sample Clock Jitter)}^2 \text{ (RMS) + (clock accuracy * reading) (seconds)} Jitter Measurement Floor \[\sum_{\text{Noise}} \frac{1}{2} \text{ Sample Clock Jitter}^2 \text{ (RMS) * conds, TIE)} Channel-Channel Deskew Range \(\frac{\text{Ey t time/div. setting, 100 ms max., each channel}}{100 \text{ MHz ± 25 ppm at 0 to 10 dBm into 50 Ohms} \]					
Volt/meter, Coulomb/m2, Farad/meter, Siemen/meter, power factor; Magnetic: Weber, Tesla, Henry, Amp/meter, Henry/meter; Energy: Joule, BTU, calorie; Rotating Machine: radian/second, frequency, revolution/second, revolution/minute, N·m, lb-ft, lb-in, oz-in, Watt, horsepower; Other: % Horizontal - Analog Channels Time/Division Range Internal timebase common to 8 input channels Time/Division Range 100 ps/div to 5 ks/div (up to 10 ks/div with 500MPT memory, 25 ks/div with 1000MPT memory, 50 ks/div w 2000MPT memory, 100 ks/div with 5000MPT memory); Roll Mode available at ≥ 100 ms/div and ≤ 5 MS/s Clock Accuracy ±1 ppm + 1 ppm/year from calibration Sample Clock Jitter Up to 10 µs Acquired Time Range: 80 fsrms (Internal Timebase Reference) Delta Time Measurement Accuracy √2 * √ (Noise SlewRate)² + (Sample Clock Jitter)² (RMS) + (clock accuracy * reading) (seconds) Jitter Measurement Floor √2 * (Sample Clock Jitter)² (RMS, seconds, TIE) Channel-Channel Deskew Range ±9 x time/div. setting, 100 ms max., each channel External Timebase Reference (Input) 10 MHz ±25 ppm at 0 to 10 dBm into 50 Ohms					
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Horizontal - Analog Channels Timebases Internal timebase common to 8 input channels Time/Division Range 100 ps/div to 5 ks/div (up to 10 ks/div with 500MPT memory, 25 ks/div with 1000MPT memory, 50 ks/div w 2000MPT memory, 100 ks/div with 5000MPT memory); Roll Mode available at ≥ 100 ms/div and ≤ 5 MS/s Clock Accuracy ±1 ppm + 1 ppm/year from calibration Sample Clock Jitter Up to 10 µs Acquired Time Range: 80 fsrms (Internal Timebase Reference) Up to 10 ms Acquired Time Range: 150 fsrms (Internal Timebase Reference) Up to 10 ms Acquired Time Range: 150 fsrms (Internal Timebase Reference) Jitter Measurement Accuracy √2 * √ (Noise / SlewRate) 2 + (Sample Clock Jitter)² (RMS) + (clock accuracy * reading) (seconds) √2 * √ (Noise / SlewRate) 2 + (Sample Clock Jitter)² (RMS, seconds, TIE) Channel-Channel Deskew Range ±9 x time/div. setting, 100 ms max., each channel External Timebase Reference (Input) 10 MHz ±25 ppm at 0 to 10 dBm into 50 Ohms		Henry/meter: Energy: Joule.	BTU, calorie: Rotating Machin	ne: radian/second. frequency. i	revolution/second.
Horizontal - Analog Channels Timebases Internal timebase common to 8 input channels Time/Division Range 100 ps/div to 5 ks/div (up to 10 ks/div with 500MPT memory, 25 ks/div with 1000MPT memory, 50 ks/div with 5000MPT memory); Roll Mode available at ≥ 100 ms/div and ≤ 5 MS/s Clock Accuracy ±1 ppm + 1 ppm/year from calibration Sample Clock Jitter Up to 10 μs Acquired Time Range: 80 fsrms (Internal Timebase Reference) Up to 10 ms Acquired Time Range: 150 fsrms (Internal Timebase Reference) Delta Time Measurement Accuracy					
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Time/Division Range 100 ps/div to 5 ks/div (up to 10 ks/div with 500MPT memory, 25 ks/div with 1000MPT memory, 50 ks/div with 2000MPT memory, 100 ks/div with 5000MPT memory); Roll Mode available at \geq 100 ms/div and \leq 5 MS/s Clock Accuracy \$\frac{\pm 1 \text{ ppm} + 1 \text{ ppm}/year from calibration}{\pm 10 \text{ ps to 10 ms Acquired Time Range: 80 fsrms (Internal Timebase Reference)}{\pm 10 \text{ Up to 10 ms Acquired Time Range: 150 fsrms (Internal Timebase Reference)}} Delta Time Measurement Accuracy \[\sum_{\text{lock BiewRate}} \sum_{\text{lock Jitter}}^2 \left(\frac{\text{Noise}}{\text{SlewRate}} \right)^2 + \left(\frac{\text{Sample Clock Jitter}}{\text{SlewRate}} \right)^2 \left(\frac{\text{RMS}}{\text{slewRate}} \right)^2 \left(\frac{\text{RMS}}{\text{slewRate}} \right)^2 \left(\frac{\text{RMS}}{\text{slewRate}} \right)^2 \left(\frac{\text{RMS}}{\text{slewRate}} \right)^2 \left(\frac{\text{Sample Clock Jitter}}{\text{slewRate}} \right)^2 \left(\frac{\text{RMS}}{\text{slewRate}} \right)^2 \left(\frac{\text{Sample Clock Jitter}}{\text{slewRate}} \right)^2 \left(\frac{\text{RMS}}{\text{slewRate}} \right)^2 \left(\frac{\text{Sample Clock Jitter}}{\text{slewRate}} \right)^2 \left(\frac{\text{RMS}}{\text{slewRate}} \right)^2 \right)^2 \right)^2 \left(\frac{\text{RMS}}{\text{slewRate}} \right)^2 \right)^2 \right)^2 \left(\frac{\text{RMS}}{\text{slewRate}} \right)^2 \right)^2 \right)^2 \right)^2 \right)^2 \right)^2 \right)^	_				
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Clock Accuracy \$\frac{\pm + 1 ppm + 1 ppm/year from calibration}{\pm to 10 \mus Acquired Time Range: 80 fsrms (Internal Timebase Reference)}{\pm to 10 ms Acquired Time Range: 150 fsrms (Internal Timebase Reference)} Delta Time Measurement Accuracy \[\sum_{ \text{Noise}} \sqrt{\sqrt{\sqrt{Noise}}} \sqrt{\sqrt{\sqrt{Noise}}} \sqrt{\sqrt{\sqrt{\sqrt{Noise}}}} \sqrt{\sqrt{\sqrt{\sqrt{Noise}}}} \sqrt{\sqrt{\sqrt{\sqrt{\sqrt{\sqrt{\sqrt{\text{p}}\sqrt{\sqrt{\sqrt{\sqrt{\sqrt{\sqrt{\sqrt{\text{Noise}}}} \sqrt{\synt{\sqrt{\sqrt{\sqrt		2000MPT memory, 100 ks/c	<u>div with 5000MPT memory); </u>	<u>Roll Mode available at ≥ 100 r</u>	ms/div and ≤ 5 MS/s
Sample Clock Jitter Up to 10 μ s Acquired Time Range: 80 fsrms (Internal Timebase Reference) Up to 10 ms Acquired Time Range: 150 fsrms (Internal Timebase Reference) Delta Time Measurement Accuracy $ \sqrt{2} * \sqrt{\left(\frac{Noise}{SlewRate}\right)^2 + (Sample Clock Jitter)^2} (RMS) + (clock accuracy * reading) (seconds) $ Jitter Measurement Floor $ \sqrt{\frac{Noise}{SlewRate}}^2 + (Sample Clock Jitter)^2 (RMS, seconds, TIE) $ Channel-Channel Deskew Range $ \pm 9 \times \text{time/div. setting, 100 ms max., each channel} $ External Timebase Reference (Input) $ 10 \text{ MHz } \pm 25 \text{ ppm at 0 to 10 dBm into 50 Ohms} $	Clock Accuracy				
Delta Time Measurement Accuracy $ \sqrt{2} * \sqrt{\frac{Noise}{SlewRate}}^2 + (Sample Clock Jitter)^2 (RMS) + (clock accuracy * reading) (seconds)} $ Jitter Measurement Floor $ \sqrt{\frac{Noise}{SlewRate}}^2 + (Sample Clock Jitter)^2 (RMS, seconds, TIE) $ Channel-Channel Deskew Range $ \pm 9 \times \text{time/div. setting, 100 ms max., each channel} $ External Timebase Reference (Input) $ 10 \text{ MHz } \pm 25 \text{ ppm at 0 to 10 dBm into 50 Ohms} $	Sample Clock .litter	Up to 10 us Acquired Time P	Range: 80 fsrms (Internal Tim	ehase Reference)	
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Jitter Measurement Floor \[\begin{align*} \leftilde{\text{Noise}} \\ \leftilde{\text{SlewRate}}\end{align*}^2 + \leftilde{\text{Sample Clock Jitter}}^2 \left(\text{RMS, seconds, TIE} \right) \\ \text{Channel-Channel Deskew Range} \pm 9 \times \text{time/div. setting, 100 ms max., each channel} \\ \text{External Timebase Reference (Input)} \text{10 MHz \pm 25 ppm at 0 to 10 dBm into 50 Ohms} \end{align*}	Delta Time Measurement Accuracy	$\sqrt{2}$ Noise $\sqrt{2}$	ala Claak littari? (BMS) : (alaak aa	ouron, * roadinal (occordo)	
Jitter Measurement Floor $\sqrt{\left(\frac{Noise}{SlewRate}\right)^2 + (Sample Clock Jitter)^2} (RMS, seconds, TIE)$ Channel-Channel Deskew Range $\pm 9 \times time/div.$ setting, 100 ms max., each channel External Timebase Reference (Input) 10 MHz ± 25 ppm at 0 to 10 dBm into 50 Ohms		SlewBate + (Samp	DIE CIOCK JILLEIJE (MIVIS) + (CIOCK AC	curacy * reading) (seconds)	
\[\langle \frac{\text{Noise}}{SlewRate} \right) + \((Sample Clock Jitter)^2 \((RMS, seconds, TIE) \) \[\frac{\text{Channel-Channel Deskew Range}}{SlewRate} \] \(\pm \) \(\text{time/div. setting, 100 ms max., each channel} \] \[\text{External Timebase Reference (Input)} \] \(\text{10 MHz} \) \(\pm \) \(\text{10 Mms max., each channel} \) \[\text{10 Mms} \] \(\text{10 Mms} \) \(\text{10 Mms}	litter Measurement Floor	Ţ, ,,,			
\(\sqrt{SlewRate} \) Channel-Channel Deskew Range ±9 x time/div. setting, 100 ms max., each channel External Timebase Reference (Input) 10 MHz ±25 ppm at 0 to 10 dBm into 50 0hms	Sitter Measurernerit FIOOI	Noise Lange Lange Noise Lange Lang	ole Clock Jitter)2 (RMS seconds T	IF)	
Channel-Channel Deskew Range ±9 x time/div. setting, 100 ms max., each channel External Timebase Reference (Input) 10 MHz ±25 ppm at 0 to 10 dBm into 50 Ohms		\\ \SlewRate \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \			
External Timebase Reference (Input) 10 MHz ±25 ppm at 0 to 10 dBm into 50 Ohms		7			
External Timehana Deference (Output) 10 MHz E 0 dDm 10 E dDm einquisite ameliand to reference being used (internal continue)					
External Timebase Reference (Output) 10 MHz, 5.0 dBm ±2.5 dBm, sinewave synchronized to reference being used (internal or external reference)	External Timebase Reference (Output)	10 MHz, 5.0 dBm ±2.5 dBm,	sinewave synchronized to re-	ference being used (internal c	or external reference)



	WaveRunner 8038HD	WaveRunner 8058HD	WaveRunner 8108HD	WaveRunner 8208HD
Acquisition - Analog Channels				
Sample Rate (Single-Shot)	10 GS/s on 8 Ch with Enhand			
Memory Length (8 Ch / 4 Ch / 2 Ch)		Stan		
(Number of segments in sequence	50 Mpts / 100 Mpts / 200 Mpts (65,535 segments)			
acquisition mode)	WR8KHD-500MPT Option:			
		125 Mpts / 250 Mpts / 500	U Mpts (65,535 segments)	
		WR8KHD-100		
		250 Mpts / 500 Mpts / 100		
		WR8KHD-200		
		500 Mpts / 1000 Mpts / 20 WR8KHD-500		
		1250 Mpts / 2500 Mpts / 50		
		1200 Mpts / 2000 Mpts / 00	700 Mpts (00,000 segments)	
		Maximum analysis memo	ory: 500 Mpts per channel	
Intersegment Time	1.5 µs			
Averaging		on sweeps; continuous avera	ging to 1 million sweeps (way	veforms of ≤ 500 Mpts)
Interpolation		t) (waveforms of ≤ 500 Mpts)		, , , , , , , , , , , , , , , , , , ,
p	, (, (
Vertical, Horizontal, Acquisition	- Digital Channels (WR8KH	D-MSO only)		
Maximum Input Frequency	500 MHz			
Minimum Detectable Pulse Width	1 ns			
Input Dynamic Range	±20 V			
Input Impedance (Flying Leads)	100 kΩ 5 pF			
Input Channels	16 Digital Channels			
Maximum Input Voltage	±30 V Peak			
Minimum Input Voltage Swing	400 mV			
Threshold Groupings	Pod 2: D15 to D8, Pod 1: D7 t	o D0		
Threshold Selections		5 V), PECL, LVDS or User Def	inad	
			ineu	
Threshold Accuracy	±(3% of threshold setting + 100 mV)			
User Defined Threshold Range	±10 V in 20 mV steps			
User Defined Hysteresis Range	100 mV to 1.4 V in 100 mV ste	eps		
Sample Rate	2.5 GS/s			
Record Length	Standard: 50 Mpts			
Channel-to-Channel Skew	Any memory option: 500 Mp	TS		
Channel-to-Channel Skew	350 ps			
Triggering System				
Modes	Normal, Auto, Single, and Sto	p (acquisition of ≤ 500 Mpts)		
-	Single (acquisition of > 500 N			
Sources		D, or Line; slope and level uniq	ue to each source (except Lin	e)
Coupling	DC, AC, HFRej, LFRej			
Pre-trigger Delay	0 to 100% of memory size			
Post-trigger Delay	No limitation			
Hold-off	From 1 ns up to 20 s or from	1 to 99,999,999 events		
Trigger and Interpolator Jitter	≤ 2.5 ps RMS (typical), < 0.1	≤ 2.5 ps RMS (typical), < 0.1 ps RMS (typical, software assisted)		
Internal Trigger Level Range	±4.1 div from center (typical)			
External Trigger Level Range	Ext (±0.4 V); Ext/10 (±4 V)			
Maximum Trigger Rate	650,000 waveforms/second			
	0.9 div @ < 10 MHz	0.9 div @ <1 0 MHz	0.9 div @ <1 0 MHz	0.9 div @ < 10 MHz
Trigger Sensitivity with Edge Trigger	0.5 div (w < 10 ivii 12			1.0 div @ < 200 MHz
(Ch 1–8)	1.0 div @ < 200 MHz	1.0 div @ < 200 MHz	1.0 div @ < 200 MHz	1.0 div (w < 200 iviriz
			1.0 div @ < 200 MHz 1.5 div @ < 500 MHz	1.5 div @ < 500 MHz
	1.0 div @ < 200 MHz	1.0 div @ < 200 MHz		1.5 div @ < 500 MHz 2.0 div @ < 1 GHz
(Ch 1-8)	1.0 div @ < 200 MHz 1.5 div @ < 350 MHz	1.0 div @ < 200 MHz 1.5 div @ < 500 MHz	1.5 div @ < 500 MHz 2.0 div @ < 1 GHz	1.5 div @ < 500 MHz 2.0 div @ < 1 GHz 2.5 div @ < 2 GHz
(Ch 1-8) External Trigger Sensitivity,	1.0 div @ < 200 MHz 1.5 div @ < 350 MHz 0.9 div @ < 10 MHz	1.0 div @ < 200 MHz	1.5 div @ < 500 MHz 2.0 div @ < 1 GHz 0.9 div @ < 10 MHz	1.5 div @ < 500 MHz 2.0 div @ < 1 GHz 2.5 div @ < 2 GHz 0.9 div @ < 10 MHz
(Ch 1-8)	1.0 div @ < 200 MHz 1.5 div @ < 350 MHz 0.9 div @ < 10 MHz 1.0 div @ < 200 MHz	1.0 div @ < 200 MHz 1.5 div @ < 500 MHz 0.9 div @ < 10 MHz 1.0 div @ < 200 MHz	1.5 div @ < 500 MHz 2.0 div @ < 1 GHz 0.9 div @ < 10 MHz 1.0 div @ < 200 MHz	1.5 div @ < 500 MHz 2.0 div @ < 1 GHz 2.5 div @ < 2 GHz 0.9 div @ < 10 MHz 1.0 div @ < 200 MHz
(Ch 1–8) External Trigger Sensitivity,	1.0 div @ < 200 MHz 1.5 div @ < 350 MHz 0.9 div @ < 10 MHz	1.0 div @ < 200 MHz 1.5 div @ < 500 MHz 0.9 div @ < 10 MHz	1.5 div @ < 500 MHz 2.0 div @ < 1 GHz 0.9 div @ < 10 MHz 1.0 div @ < 200 MHz 1.5 div @ < 500 MHz	1.5 div @ < 500 MHz 2.0 div @ < 1 GHz 2.5 div @ < 2 GHz 0.9 div @ < 10 MHz 1.0 div @ < 200 MHz 1.5 div @ < 500 MHz
(Ch 1–8) External Trigger Sensitivity, Edge Trigger	1.0 div @ < 200 MHz 1.5 div @ < 350 MHz 0.9 div @ < 10 MHz 1.0 div @ < 200 MHz 1.5 div @ < 350 MHz	1.0 div @ < 200 MHz 1.5 div @ < 500 MHz 0.9 div @ < 10 MHz 1.0 div @ < 200 MHz 1.5 div @ < 500 MHz	1.5 div @ < 500 MHz 2.0 div @ < 1 GHz 0.9 div @ < 10 MHz 1.0 div @ < 200 MHz 1.5 div @ < 500 MHz 4.5 div @ < 1 GHz	1.5 div @ < 500 MHz 2.0 div @ < 1 GHz 2.5 div @ < 2 GHz 0.9 div @ < 10 MHz 1.0 div @ < 200 MHz 1.5 div @ < 500 MHz 4.5 div @ < 1 GHz
(Ch 1–8) External Trigger Sensitivity,	1.0 div @ < 200 MHz 1.5 div @ < 350 MHz 0.9 div @ < 10 MHz 1.0 div @ < 200 MHz	1.0 div @ < 200 MHz 1.5 div @ < 500 MHz 0.9 div @ < 10 MHz 1.0 div @ < 200 MHz	1.5 div @ < 500 MHz 2.0 div @ < 1 GHz 0.9 div @ < 10 MHz 1.0 div @ < 200 MHz 1.5 div @ < 500 MHz	1.5 div @ < 500 MHz 2.0 div @ < 1 GHz 2.5 div @ < 2 GHz 0.9 div @ < 10 MHz 1.0 div @ < 200 MHz 1.5 div @ < 500 MHz



TimesTone	WaveRunner 8038HD WaveRunner 8058HD WaveRunner 8108HD WaveRunner 8208HD
<u>Trigger Types</u>	
Edge	Triggers when signal meets slope (positive, negative, or either) and level condition.
Width	Triggers on positive or negative glitches with selectable widths. Minimum width: 750 ps, maximum width: 20 s
Glitch	Triggers on positive or negative glitches with selectable widths. Minimum width: 750 ps, maximum width: 20 s
Window	Triggers when signal exits a window defined by adjustable thresholds.
Pattern	Logic combination (AND, NAND, OR, NOR) of 9 inputs (8 channels and external trigger input). Each source can be high, low, or don't care. The high and low level can be selected independently. Triggers at start or end of pattern.
Runt	Trigger on positive or negative runts defined by two voltage limits and two time limits. Select between 1 ns and 20 ns.
Slew Rate	Trigger on edge rates. Select limits for dV, dt, and slope. Select edge limits between 1 ns and 20 ns.
Interval	Triggers on intervals selectable between 1 ns and 20 s.
Dropout	Triggers if signal drops out for longer than selected time between 1 ns and 20 s.
Measurement	Select from a large number of measurement parameters to trigger on a measurement value with qualified limits.
Multi-stage: Qualified	Triggers on any input source only if a defined state or edge occurred on another input source. Delay between sources is selectable by time or events.
Multi-stage: Qualified First	In Sequence acquisition mode, triggers repeatably on event B only if a defined pattern, state or edge (event A) is satisfied in the first segment of the acquisition. Holdoff between sources is selectable by time or events.
Low Speed Serial Protocol Trigge	
	I2C, I3C, SPI (SPI, SSPI, SIOP), UART-RS232, CAN1.1, CAN2.0, CAN FD, LIN, FlexRay, SENT, MIL-STD-1553, AudioBus (I2S, LJ, RJ, TDM), USB1.x/2.0, SPMI
Measurement Tools	
Measurement Functionality	Display up to 12 measurement parameters together with statistics including mean, minimum, maximum, standard deviation, and total number. Each occurrence of each parameter is measured and added to the statistics table. Histicons provide a fast, dynamic view of parameters and waveshape characteristics. Parameter math allows addition, subtraction, multiplication, or division of two different parameters. Parameter gates define the location for measurement on the source waveform. Parameter accept criteria define allowable values based on range setting or waveform state.
Measurement Parameters - Horizontal and Jitter	Cycles (number of), Delay (from trigger, 50%), Δ Delay (50%), Duty Cycle (50%, @level), Edges (number of, @level), Fall Time (90-10, @levels), Frequency (50%, @level), Half Period (@level), Hold Time (@level), N Cycle Jitter (peakpeak), Number of Points, Period (50%, @level), Δ Period (@level), Phase (@level), Rise Time (10-90, @levels), Setup (@levels), Skew (@levels), Slew Rate (@levels), Time Interval Error (@level), Time (@level), Δ Time (@level), Width (50%, @level), Δ Width (@level), X(value)@max, X(value)@min
Measurement Parameters - Vertical	Amplitude, Base, Level@X, Maximum, Mean, Median, Minimum, Peak-to-Peak, RMS, Std. Deviation, Top
Measurement Parameters - Pulse	Area, Base, Fall Time (90-10, 80-20, @levels), Overshoot (positive, negative), Rise Time (10-90, 80-20, @levels), Top, Width (50%)
Measurement Parameters - Statistical (on Histograms)	Full Width (@HalfMax, @%), Amplitude, Base, Peak@MaxPopulation, Maximum, Mean, Median, Minimum, Mode, Range, RMS, Std. Deviation, Top, X(value)@Peak, Peaks (number of), Percentile, Population (@bin, total)
Math Tools	
Math Functionality	Display up to 12 math functions traces (F1-F12). The easy-to-use graphical interface simplifies setup of up to two operations on each function trace, and function traces can be chained together to perform math-on-math.
Math Operators - Basic Math	Average (summed), Average (continuous), Difference (-), Envelope, Floor, Invert (negate), Product (x), Ratio (/), Reciprocal, Rescale (with units), Roof, Sum (+)
Math Operators - Digital (incl. with MSO option)	Digital AND, Digital DFlipFlop, Digital NAND, Digital NOR, Digital NOT, Digital OR, Digital XOR
Math Operators - Filters	Enhanced Resolution (ERes) to 15 bits vertical, Interpolate (cubic, quadratic, sinx/x)
Math Operators - Frequency Analysis	FFT (power spectrum, magnitude, phase, power density, real, imaginary, magnitude squared) up to full analysis memory length. Select from Rectangular, VonHann, Hamming, FlatTop and Blackman Harris windows.
Math Operators - Functions	Absolute value, Correlation (two waveforms), Derivative, Deskew (resample), Exp (base e), Exp (base 10), Integral, Invert (negate), Log (base e), Log (base 10), Reciprocal, Rescale (with units), Square, Square Root, Zoom (identity)
Math Operators - Other	Segment, Sparse
Measurement and Math Integrat	ion Histogram of statistical distributions of up to 2 billion measurements. Trend (datalog) of up to 1 million
	measurements. Track (measurement vs. time, time-correlated to acquisitions) of any parameter. Persistence histogram and persistence trace (mean, range, sigma).
Pass/Fail Testing	
	Display up to 12 Pass/Fail queries using a Single or Dual Parameter Comparison (compare All values, or Any value $<$, \le , $=$, $>$, \ge , within limit $\pm\Delta$ value or $\%$) or Mask Test (pre-defined or user-defined mask, waveform All In, All Out, Any In, or Any Out conditions). Combine queries into a boolean expression to Pass or Fail IF "All True", "All False", "Any True", "Any False", or groups of "All" or "Any", with following THEN Save (waveforms), Stop (test), (sound) Alarm, (send) Pulse, (save) LabNotebook or other User(-defined) Action.



	WaveRunner 8038HD	WaveRunner 8058HD	WaveRunner 8108HD	WaveRunner 8208HD
Display System				
Size	Color 15.6" widescreen capa	citive touch screen		
Resolution	Full HD (1920 x 1080 pixels)			
Number of Traces	Display a maximum of 40 tra	aces. Simultaneously display o	channel, zoom, memory and	math traces.
Grid Styles	Auto, Single, Dual, Triplex, Qu Supports Normal Display Mo individually selectable grid st	ad, Octal, Tandem, Triad, Qua de (1 grid style, selectable) or yles). Q-Scape tabbed display	ttro, Twelve, Sixteen, Twenty, ⁻ Q-Scape Display Mode (4 di: /s may be viewed in Single, D	X-Y, Single+X-Y, Dual+X-Y. fferent tabs, each with ual, or Mosaic mode.
Waveform Representation	Sample dots joined, or samp	le dots only		
Processor/CPU				
Type	Intel® Core i5-6500 Quad Co	re, 3.2 GHz (or better)		
Processor Memory	16 GB standard			
Operating System	Microsoft Windows® 10			
Real Time Clock	Date and time displayed with	waveform in hardcopy files. SI	NTP support to synchronize t	o precision internal clocks.
Connectivity				
Ethernet Port	2 x 10/100/1000BaseT Ethe			
USB Host Ports	4 side USB 3.1 Gen1 ports, 2			
USB Device Port	1 USBTMC over USB 3.1 Ger			
GPIB Port (Optional) External Monitor Port	Supports IEEE-488.2 (Exteri			
	1 x DisplayPort, supports up 1 x HDMI, supports up to 409	96x2304 @ 60 Hz	-	_
Remote Control		or LeCroy Remote Command	Set	
Network Communication Standard	VICP or VXI-11, LXI Compatib	ole		
Power Requirements				
Voltage	90 to 264 Vrms, 47 to 63 Hz			
Voltage	90 to 132 Vrms, 380 to 420 F	Hz		
Nominal Power Consumption	400 W / 400 VA			
Max Power Consumption	500 W / 500 VA			
e a constant				
Environmental				
Temperature (Operating)	+5 °C to +40 °C			
Temperature (Non-Operating)	-20 °C to +60 °C	()		
Humidity (Operating)		non-condensing) up to +31 °C elative humidity (non-condens		
Humidity (Non-Operating)		non-condensing) as tested pe	er MIL-PRF-28800F	
Altitude (Operating)	Up to 10,000 ft (3048 m) at o	or below +30 °C		
Altitude (Non-Operating)	Up to 40,000 ft (12,192 m)			
Random Vibration (Operating)		minutes in each of three orth		
Random Vibration (Non-Operating)		minutes in each of three ortho		10
Functional Shock	30 g peak, haif sine, 11 ms puls	e, 3 shocks (positive and negative	ve) in each of three orthogonal a	axes, 18 snocks total
Size and Weight				
Dimensions (HWD)	13.6" H x 17.5" W x 7.7" D (34	15 mm x 445 mm x 196 mm)		
Weight	24.4 lbs (11.1kg)			
Certifications				
CE Certification	CE compliant, UL and cUL lis	ted; conforms to UL 61010-1	(3rd Edition), UL 61010-2-03	0 (1st Edition)
UL and cUL Listing	CAN/CSA C22.2 No. 61010-1		•	•
Warranty and Service				
	3-year warranty; calibration r upgrades, and calibration se	ecommended annually. Optiorvices.	nal service programs include	extended warranty,

ORDERING INFORMATION



Product Code

Product Description	Product Code
WaveRunner 8000HD Oscilloscopes	
350 MHz, 8 Ch, 12 Bits, 10 GS/s, 50 Mpts/Ch	WaveRunner 8038HD
High Definition Oscilloscope	
with 15.6" 1920x1080 capacitive touch screen	
and 4K extended desktop	
500 MHz, 8 Ch, 12 Bits, 10 GS/s, 50 Mpts/Ch	WaveRunner 8058HD
High Definition Oscilloscope	
with 15.6" 1920x1080 capacitive touch screen	
and 4K extended desktop	
1 GHz, 8 Ch, 12 Bits, 10 GS/s, 50 Mpts/Ch	WaveRunner 8108HD
High Definition Oscilloscope	
with 15.6" 1920x1080 capacitive touch screen	
and 4K extended desktop	
2 GHz, 8 Ch, 12 Bits, 10 GS/s, 50 Mpts/Ch	WaveRunner 8208HD
High Definition Oscilloscope	
with 15.6" 1920x1080 capacitive touch screen	
and 4K extended desktop	

Included with Standard Configurations
-10, 500 MHz passive probe (Oty. 4) protecti

 $\div 10,500$ MHz passive probe (Qty. 4), protective cover, Getting Started Guide, Microsoft Windows® 10, commercial NIST traceable calibration with certificate, power cable for the destination country, 3-year warranty

Mixed Signal Solutions

Mixed Signal Oscilloscope (incl. 16-channel digital	WR8KHD-MS0
leadset, 22 extra large gripper probes, 20 ground	
extenders, 5 flexible ground leads and license)	
MSO License (without accessories)	WR8KHD-MSO-LICENSE

Memory Upgrade Options

500 Mpt/2 Ch (250 Mpt/4 Ch, 125 Mpt/8 Ch)	WR8KHD-500MPT
1 Gpt/2 Ch (500 Mpt/4 Ch, 250 Mpt/8 Ch)	WR8KHD-1000MPT
2 Gpt/2 Ch (1 Gpt/4 Ch, 500 Mpt/8 Ch)	WR8KHD-2000MPT
5 Gpt/2 Ch (2.5 Gpt/4 Ch. 1.25 Gpt/8 Ch)	WR8KHD-5000MPT

CPU, Computer and Other Hardware Options

Additional Standard Solid State Drive	WR8KHD-RSSD-02
16 GB to 32 GB CPU RAM Upgrade*	WR8KHD-UPG-32GBRAM

^{* 32} GB RAM upgrade is included with all memory upgrade options.

Oscilloscope Synchronization Options

16-channel OscilloSYNC Software (combines	WR8KHD-16CH-SYNCH
two WaveRunner/MDA 8000HD oscilloscopes)	

Serial Trigger and Decode Options

ocitat irigget arta becode o	P (10110
MIL-STD-1553 Trigger & Decode	WR8KHD-1553 TD
MIL-STD-1553 Trigger, Decode,	WR8KHD-1553 TDME
Measure/Graph & Eye Diagram	
8b10b Decode	WR8KHD-8B10B D
ARINC 429 Symbolic Decode	WR8KHD-ARINC429BUS D SYMBOLIC
ARINC 429 Symbolic Decode,	WR8KHD-ARINC429BUS DME SYMBOLIC
Measure/Graph & Eye Diagram	
AudioBus Trigger & Decode	WR8KHD-AUDIOBUS TD
AudioBus Trigger, Decode & Graj	ph WR8KHD-AUDIOBUS TDG
CAN FD Trigger & Decode	WR8KHD-CAN FDBUS TD
CAN FD Trigger, Decode,	WR8KHD-CAN FDBUS TDME
Measure/Graph & Eye Diagram	
CAN FD Symbolic Trigger,	WR8KHD-CAN FDBUS TDME SYMBOLIC
Decode, Measure/Graph	

roduct	Descrip	tion		
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Serial Trigger and Decode Options	(cont'd)
CAN Trigger & Decode	WR8KHD-CANBUS TD
CAN Trigger, Decode,	WR8KHD-CANBUS TDME
Measure/Graph& Eye Diagram	
	R8KHD-CANBUS TDME SYMBOLIC
Measure/Graph & Eye Diagram	
DigRF 3G Decode	WR8KHD-DIGRF3GBUS D
DigRF V4 Decode	WR8KHD-DIGRFV4BUS D
MIPI D-PHY CSI-2 & DSI Decode	WR8KHD-DPHYBUS D
Embedded Bundle: I2C, SPI, UART-RS23	2 WR8KHD-EMB TD
Trigger & Decode	
Embedded Bundle: I2C, SPI, UART-RS23	2 WR8KHD-EMB TDME
Trigger, Decode, Measure/Graph	
& Eye Diagram	
ENET Decode	WR8KHD-ENETBUS D
FlexRay Trigger & Decode	WR8KHD-FLEXRAYBUS TD
FlexRay Trigger, Decode,	WR8KHD-FLEXRAYBUS TDMP
Measure/Graph & Physical Layer Tests	
I2C Trigger & Decode	WR8KHD-I2CBUS TD
I2C Trigger, Decode,	WR8KHD-I2CBUS TDME
Measure/Graph & Eye Diagram	·
I3C Trigger & Decode	WR8KHD-I3CBUS TD
I3C Trigger, Decode,	WR8KHD-I3CBUS TDME
Measure/Graph & Eye Diagram	· · · · · · · · · · · · · · · · · · ·
LIN Trigger & Decode	WR8KHD-LINBUS TD
LIN Trigger, Decode,	WR8KHD-LINBUS TDME
Measure/Graph & Eye Diagram	
Manchester Decode	WR8KHD-MANCHESTERBUS D
MDIO Decode	WR8KHD-MDIOBUS D
NRZ Decode	WR8KHD-NRZBUS D
SENT Trigger & Decode	WR8KHD-SENTBUS TD
SENT Trigger, Decode,	WR8KHD-SENTBUS TDME
Measure/Graph & Eye Diagram	
SpaceWire Decode	WR8KHD-SPACEWIREBUS D
SPI Trigger & Decode	WR8KHD-SPIBUS TD
SPI Trigger, Decode,	WR8KHD-SPIBUS TDME
Measure/Graph & Eye Diagram	
SPMI Decode	WR8KHD-SPMIBUS D
SPMI Trigger, Decode,	WR8KHD-SPMIBUS TDME
Measure/Graph & Eye Diagram	
UART-RS232 Trigger & Decode	WR8KHD-UART-RS232BUS TD
UART-RS232 Trigger, Decode,	WR8KHD-UART-RS232BUS TDME
Measure/Graph & Eye Diagram	
USB 2.0 Trigger & Decode	WR8KHD-USB2BUS TD
USB 2.0 Trigger, Decode,	WR8KHD-USB2BUS TDME
Measure/Graph & Eye Diagram	WEG 1415 HODG HOTELT
USB 2.0 HSIC Decode	WR8vKHD-USB2-HSICBUS D

Serial Data Compliance Test Options

Geriai Bata Gerriphanice rect optione	
QualiPHY 1000Base-T1 Compliance Software	QPHY-1000BASE-T1*
QualiPHY BroadR-Reach Software	QPHY-BROADR-REACH*
QualiPHY Ethernet 10/100/1000BT Software	QPHY-ENET*
QualiPHY MOST150 Software	QPHY-MOST150
QualiPHY MOST50 Software	QPHY-MOST50
QualiPHY USB 2.0 Software	QPHY-USB‡
10/100/1000Base-T Ethernet Test Fixture	TF-ENET-B**
USB 2.0 Compliance Test Fixture	TF-USB-B

Debug Toolkit Options

Debug roomit options		
100Base-T1 and 1000Base-T1	WR8KHD-AUT	D-ENET-TOOLKIT
Debug Toolkit		
Automotive Ethernet Breakout Test Fixtur	e for	TF-AUTO-ENET
100Base-T1 and 1000Base-T1 Debug Too	olkit	

& Eye Diagram

^{**} Includes ENET-2CAB-SMA018 and ENET-2ADA-BNCSMA

ORDERING INFORMATION

Product Description	Product Code	Product Description	Product Code
Serial Data Analysis Options		Probes (cont'd)	
Serial Data Analysis Software (single-lane eye, iitter and noise measurements)	WR8KHD-SDAIII	30 A, 50 MHz Current Probe - AC/DC, 30 Arms, 50 A peak pulse, 1.5-meter cable	CP030
Eye Doctor II Software (channel & fixture de-embedding/emulation, Tx/Rx equalization)	WR8KHD-EYEDRII	30 A, 10 MHz Current Probe - AC/DC, 30 Arms, 50 A peak pulse, 3-meter cable	CP030-3M
Virtual Probe Software (advanced WR8	KHD-VIRTUALPROBE	30 A, 50 MHz High Sensitivity Current Probe - AC/DC, 30 Arms, 50 A peak pulse, 1.5-meter cable	CP030A
de-embedding, emulation and virtual probing) Serial Data Mask Software	WR8KHD-SDM	30 A, 100 MHz Current Probe - AC/DC, 30 Arms, 50 A peak pulse, 1.5-meter cable	CP031
Cable De-Embedding Software WR8	BKHD-CBL-DE-EMBED	30A, 100 MHz High Sensitivity Current Probe - AC/DC, 30 Arms, 50 A peak pulse, 1.5-meter cable	CP031A
Power Analysis Options Power Analyzer Software	WR8KHD-PWR	150 A, 10 MHz Current Probe - AC/DC, 150 Arms; 500 A peak pulse, 2-meter cable	CP150
Digital Power Management Analysis Software WR8k	KHD-DIG-PWR-MGMT HREEPHASEPOWER	150 A, 5 MHz Current Probe - AC/DC, 150 Arms, 500 A peak pulse, 6-meter cable	CP150-6M
3-Phase Harmonics Calculation WR8KHD-THREE	EPHASEHARMONICS	500 A, 2 MHz Current Probe - AC/DC, 500 Arms, 700 A peak pulse, 6-meter cable	CP500
Software (requires		Deskew Calibration Source	DCS025
WR8KHD-THREEPHASEPOWER)		Programmable Current Sensor to ProBus Adapter (for third-party current sensors)	CA10
JitKit Software (clock/clock-data jitter analysis	WR8KHD-JITKIT	Set of 4 CA10 Programmable Current Sensor to ProBus Adapters (for third-party current sensors)	CA10-QUADPAK
with statistical, spectral and jitter overlay)		100:1 400 MHz 50 MΩ 1 kV High Voltage Probe	HVP120
District Filesian Octions		100:1 400 MHz 50 MΩ 4 kV High Voltage Probe	PPE4KV
Digital Filtering Options	WDOW ID DEDO	1000:1 400 MHz 50 M Ω 5 kV High Voltage Probe	PPE5KV
Digital Filter Software	WR8KHD-DFP2	1000:1 400 MHz 5 M Ω / 50 M Ω 6 kV High Voltage Prob	
Other Software Options		TekProbe to ProBus Probe Adapter	TPA10
EMC Pulse Parameter	WR8KHD-EMC	Optical-to-Electrical Converter - 500-870 nm, ProBus BNC connector	OE425
	VR8KHD-SPECTRUM	Optical-to-Electrical Converter -	OE455
	R8KHD-VECTORLINQ	950-1630 nm, ProBus BNC connector	OL+00
Advanced Customization	WR8KHD-XDEV	1 kV, 25 MHz High Voltage Differential Probe	HVD3102A
Remote Control/Network Options		1 kV, 25 MHz High Voltage Differential Probe (without tip accessories)	HVD3102A-NOACC
External USB2 to GPIB Adaptor	USB2-GPIB	1 kV, 120 MHz High Voltage Differential Probe	HVD3106A
General Accessories		1 kV, 120 MHz High Voltage Differential Probe (without tip accessories)	HVD3106A-NOACC
WaveRunner 8000HD Rackmount Kit WF	88KHD-RACKMOUNT	1 kV, 80 MHz High Voltage Differential Probe - 6-meter cable and Auto Zero disconnect	HVD3106A-6M
Instrument Cart (with additional shelf and drawer)	OC1024-A	2 kV, 120 MHz High Voltage Differential Probe	HVD3206A
Probes		2 kV, 80 MHz High Voltage Differential Probe - 6-meter cable and Auto Zero disconnect	HVD3206A-6M
Power/Voltage Rail Probe - 4 GHz bandwidth,	RP4030	6 kV, 100 MHz High Voltage Differential Probe	HVD3605A
1.2x attenuation, ±30 V offset, ±800 mV	L III / E O 1 O O	700 V, 25 MHz High Voltage Differential Probe (÷10, ÷10	
High Voltage Fiber Optic Probe, 60 MHz bandwidth	HVF0103	7.5 GHz Low Capacitance Passive Probe (\div 10, 1 k Ω ; \div 20, 500 Ω)	PP066
500 MHz Passive Probe, 2.5mm, 10:1, 10 MΩ	PP021	(·10, 1 kΩ, ·20, 300 Ω)	
500 MHz Passive Probe, 5mm, 10:1, 10 MΩ	PP025 ZS1000		
1 GHz, 0.9 pF, 1 MΩ High Impedance Active Probe Set of 4 ZS1000 Active Probes	ZS1000-QUADPAK	Customer Service	
1.5GHz , 0.9pF , $1 \text{M}\Omega$ High Impedance Active Probe	ZS1500 ZS1500	Teledyne LeCroy oscilloscopes and probes are designed, built,	and tested to ensure
Set of 4 ZS1500 Active Probes	ZS1500-QUADPAK		
200 MHz, 3.5 pF, 1 M Ω Active Differential Probe, ±20 \		scopes are fully warranted for three years and our probes are	2
500 MHz, 1.0 pF Active Differential Probe, ±8 V	ZD500	This warranty includes:	,
1 GHz, 1.0 pF Active Differential Probe, ±8 V	ZD1000	No charge for return shipping	
1.5 GHz, 1.0 pF Active Differential Probe, ±8 V	ZD1500	Long-term 7-year support	
500 MHz, Active Differential Probe (÷1, ÷10, ÷100)	AP033	Upgrade to latest software at no charge	



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